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04 AUG 2000

FORM PTO-1449  
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY. DOCKET NO. :

BIERBAUMER ET AL-2 PCT

SERIAL NO.

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(Use several sheets if necessary)

APPLICANT: HANS-PETER BIERBAUMER ET AL

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## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
MRL	AA	3,142,759	07/28/64	JEFFERSON ET AL	250	106	_____
MRL	AB	3,564,241	02/16/71	LUDWIG	250	52	_____
MRL	AC	4,446,374	05/10/84	IVANOV ET AL	250	492.3	_____
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
							YES	NO
MRL	AL	WO 94/22162	09/94	INTERNATIONAL	_____	_____	✓	
MRL	AM	EP 0 731 626	09/96	EUROPEAN	_____	_____	✓	
	AN							
	AO							
	AP							

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

MRL	AR	—	Abstracts of Russian Patents, RU 2076001, "Method and Apparatus for Radiation-Chemical Treatment of Liquids"					
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MRL	AT	—	Z. Zimek et al, "EB industrial facility for radiation sterilization of medical devices", Radiation Physics and Chemistry, vol. 42, no. 1-3, 1993, pages 571-572, XP002111464					
MRL	AU	—	Allen J.T. et al, "A fully integrated 10 MeV electron beam sterilization system", Radiation Physics and Chemistry, vol. 46, no. 4, 12 Oct. 1995, pages 457-460, XP004051111					

EXAMINER

Mayer R. Chubij

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03/12/04

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

MRL	AR	—	Proceedings of the 10 <sup>th</sup> International Meeting on Radiation Processing, 11-16 May 1997, Anaheim, USA Radiation Physics and Chemistry, vol. 52, NR 1-6 (1998-6-1), pages 491-494, Hackett JL, "A state of the art electron beam sterilization facility - An integrated system" XP002112487
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Mongul Chulaj

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MRC	AR	—	Burns P. et al, "The measurement, control, and validation of critical parameters in an electron beam sterilization facility", Nuclear Instruments & Methods in Physics Research, Section-B, Beam Interactions with Materials and Atoms, vol. 113, no. 1, 1 June 1996, pages 96-98, XP004007773
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	AT		

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Morgan R. Chubb

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